# **Power MOSFET**

# 25 V, 193 A, Single N-Channel, SO-8FL

#### **Features**

- Integrated Schottky Diode
- Optimized Design to Minimize Conduction and Switching Losses
- Optimized Package to Minimize Parasitic Inductances
- Optimized material for improved thermal performance
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### **Applications**

- High Performance DC-DC Converters
- System Voltage Rails
- Netcom, Telecom
- Servers & Point of Load

### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Units
Drain-to-Source Voltage	$V_{DSS}$	25	V
Gate-to-Source Voltage	$V_{GS}$	±20	V
Continuous Drain Current $R_{\theta JA}$ ( $T_A = 25^{\circ}C$ , Note 1)	Ι <sub>D</sub>	37	А
Power Dissipation $R_{\theta JA}$ (T <sub>A</sub> = 25°C, Note 1)	P <sub>D</sub>	3.13	W
Continuous Drain Current $R_{\theta JC}$ ( $T_C = 25^{\circ}C$ , Note 1)	Ι <sub>D</sub>	193	Α
Power Dissipation $R_{\theta JC}$ ( $T_C = 25^{\circ}C$ , Note 1)	P <sub>D</sub>	83	W
Pulsed Drain Current (t <sub>p</sub> = 10 μs)	I <sub>DM</sub>	449	Α
Single Pulse Drain-to-Source Avalanche Energy (Note 1) (I <sub>L</sub> = 38 A <sub>pk</sub> , L = 0.3 mH)	E <sub>AS</sub>	223	mJ
Drain to Source dV/dt	dV/dt	7	V/ns
Maximum Junction Temperature	T <sub>J(max)</sub>	150	°C
Storage Temperature Range	T <sub>STG</sub>	–55 to 150	°C
Lead Temperature Soldering Reflow (SMD Styles Only), Pb-Free Versions (Note 2)	T <sub>SLD</sub>	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Values based on copper area of 645 mm<sup>2</sup> (or 1 in<sup>2</sup>) of 2 oz copper thickness and FR4 PCB substrate.
- For more information, please refer to our Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.
- 3. This is the absolute maximum rating. Parts are 100% UIS tested at  $T_J$  = 25°C,  $V_{GS}$  = 10 V,  $I_L$  = 26 A,  $E_{AS}$  = 101 mJ.

#### **THERMALCHARACTERISTICS**

Parameter	Symbol	Max	Units
Thermal Resistance, Junction-to-Ambient (Note 1 and 4) Junction-to-Case (Note 1 and 4)	$R_{ heta JA} \ R_{ heta JC}$	40.0 1.5	°C/W

4. Thermal Resistance  $R_{\theta JA}$  and  $R_{\theta JC}$  as defined in JESD51–3.



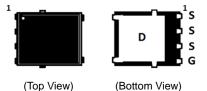
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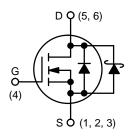
V <sub>GS</sub>	MAX R <sub>DS(on)</sub> TYP Q <sub>G</sub>	
4.5 V	$2.3~\text{m}\Omega$	17.4 nC
10 V	1.4 mΩ	39.3 nC

#### **PIN CONNECTIONS**

SO8-FL (5 x 6 mm)



#### **N-CHANNEL MOSFET**



#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 6 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condit	ion	Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1$	250 μΑ	25			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				18.6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V	T <sub>J</sub> = 25°C			500	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	= +20 V			+100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.2		2.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	55 50 5			3.3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		1.1	1.4	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		1.6	2.3	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 12 V, I <sub>D</sub>	= 15 A		84		S
CHARGES, CAPACITANCES & GATE RESI	STANCE						
Input Capacitance	C <sub>ISS</sub>				2652		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, } f = 1 \text{ MHz}$	, V <sub>DS</sub> = 12 V		1644		
Reverse Transfer Capacitance	C <sub>RSS</sub>	1			94		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 12 V; I <sub>D</sub> = 30 A			18.7		
Threshold Gate Charge	Q <sub>G(TH)</sub>				2.8		nC
Gate-to-Source Charge	$Q_{GS}$				7.5		
Gate-to-Drain Charge	$Q_{GD}$				4.3		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 10 \text{ V}, V_{DS} = 12$	! V; I <sub>D</sub> = 30 A		40.9		nC
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25°C	;		1.0	2	Ω
SWITCHING CHARACTERISTICS, V <sub>GS</sub> = 4.	<b>5 V</b> (Note 5)						
Turn-On Delay Time	t <sub>d(ON)</sub>				13.5		
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{DD} = 12 \text{ V}, I_{D} = 15 \text{ A},$ $R_{G} = 3.0 \Omega$			46.7		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				24.8		
Fall Time	t <sub>f</sub>				7.72		
SWITCHING CHARACTERISTICS, V <sub>GS</sub> = 10	<b>V</b> (Note 5)						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 12 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			10		
Rise Time	t <sub>r</sub>				35.7		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				32.3		
Fall Time	t <sub>f</sub>				4.93		
DRAIN-SOURCE DIODE CHARACTERISTIC	cs						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V},$ $I_{S} = 2.0 \text{ A}$	$T_J = 25$ °C $T_J = 125$ °C		0.38 0.29	0.6	V
Reverse Recovery Time	t <sub>RR</sub>	- IJ = 123 C			41		
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			20.2		ns
Discharge Time	t <sub>b</sub>				20.8		1
Reverse Recovery Charge	Q <sub>RR</sub>				30		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

6. Switching characteristics are independent of operating junction temperatures.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
PACKAGE PARASITIC VALUES						
Source Inductance	L <sub>S</sub>			0.57		nΗ
Drain Inductance	L <sub>D</sub>	T <sub>A</sub> = 25°C		0.13		nΗ
Gate Inductance	L <sub>G</sub>			1.37		nΗ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

6. Switching characteristics are independent of operating junction temperatures.

### TYPICAL CHARACTERISTICS

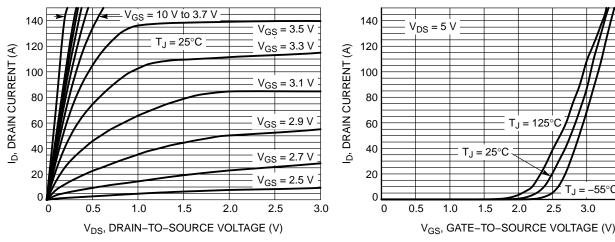


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

-55°C

3.5

3.0

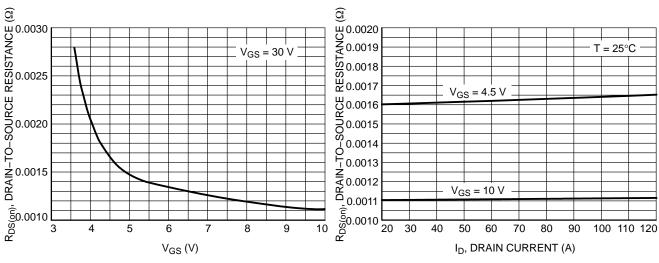


Figure 3. On-Resistance vs. V<sub>GS</sub>

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage** 

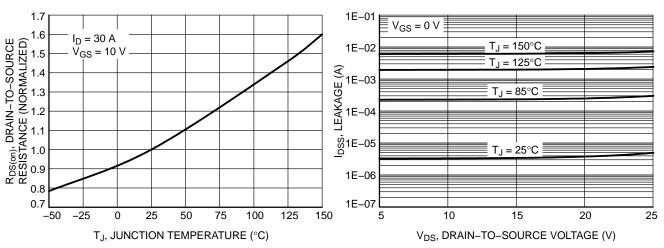


Figure 5. On-Resistance Variation with **Temperature** 

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

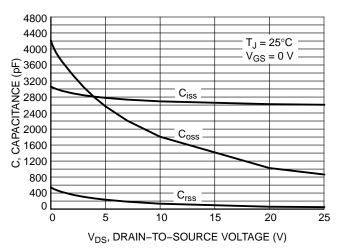


Figure 7. Capacitance Variation

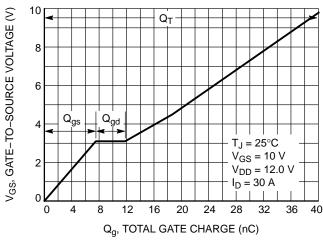


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

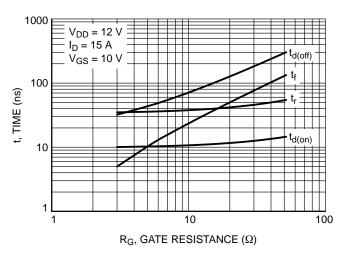


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

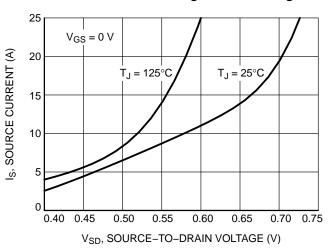


Figure 10. Diode Forward Voltage vs. Current

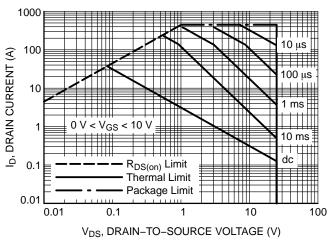


Figure 11. Maximum Rated Forward Biased Safe Operating Area

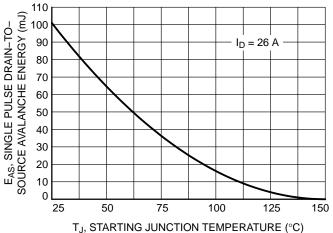


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

### TYPICAL CHARACTERISTICS

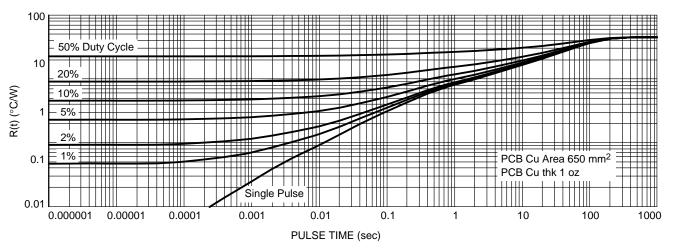


Figure 13. Thermal Characteristics

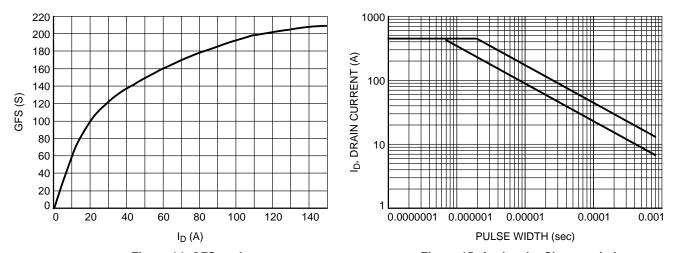


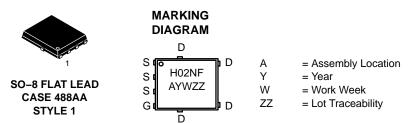
Figure 14. GFS vs. I<sub>D</sub>

Figure 15. Avalanche Characteristics

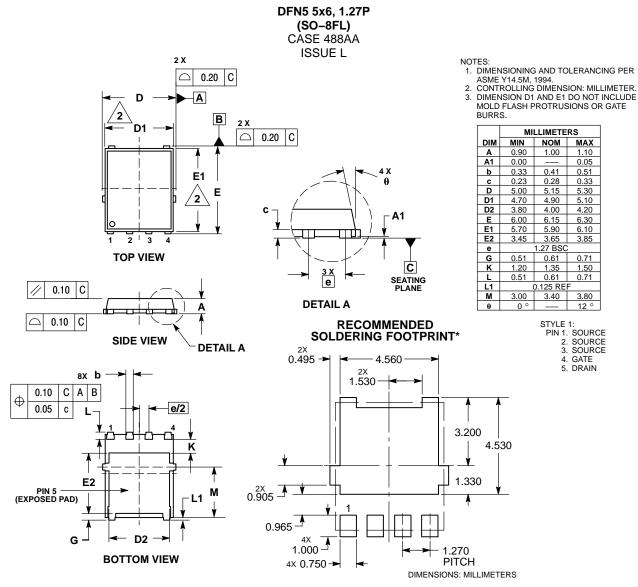
### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4H02NFT1G	SO8-FL (Pb-Free)	1500 / Tape & Reel
NTMFS4H02NFT3G	SO8-FL (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



#### PACKAGE DIMENSIONS



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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